



In vacuo chemical characterization of PFCs in NSTX-U with MAPP

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Diagnostic research plans for FY2016-2018 May 27th, 2016









MAPP Status update

- MAPP techniques:
 - -X ray photoelectron spectroscopy (XPS)
 - Currently fully operational in remote and local modes
 - Thermal Desorption Spectroscopy (TDS)
 - Tested in LTX, however needs to resolve issue with RGAs (two RGAs broken in NSTX-U so far).
 - Sample heaters need conditioning and test in NSTX-U.
 - Ion Scattering Spectroscopy and Direct Recoils Spectroscopy
 - Ion source and gas manifold system installed and controlled remotely.
 - Ion source needs conditioning.
 - Need calibration and testing
 - Between shots analysis
 - Needs connectivity and wiring.

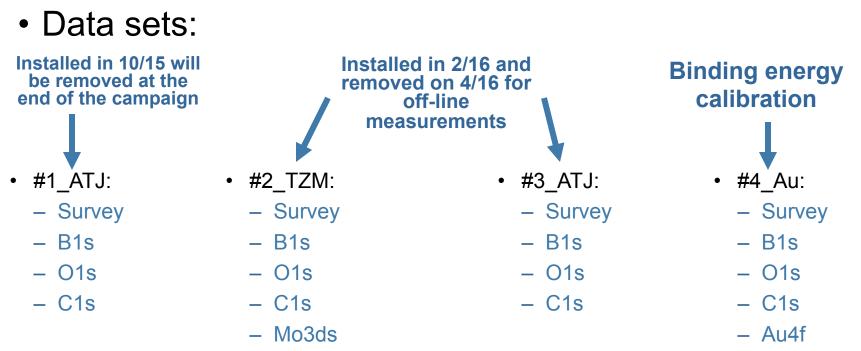


MAPP Status Update

- Currently XPS data collected in semi-remote mode i.e. manual insertion/retraction but remote control of XPS system is possible:
 - Monitoring chemistry of samples conditioned with boronizations and exposed to D+ plasmas.
- Several samples have been extracted from MAPP during the campaign for controlled laboratory experiments (collab. with B. Koel @ Princeton U.)
 - Boronized ATJ and TZM exposed to plasmas.
 - Post-mortem characterization with XPS-depth profile
 - Boronized ATJ and TZM unexposed to plasmas:
 - Controlled D+ irradiation in HR-XPS
 - Post-irradiation TDS

MAPP Methodology at NSTX-U

- XPS scans were collected after each boronization in biweekly and weekly modes, scans were collected after boronization and plasma operations in daily mode.
- XPS data collected every night after plasma operations.



Acquisition time ~40 min per data set with optimized settings

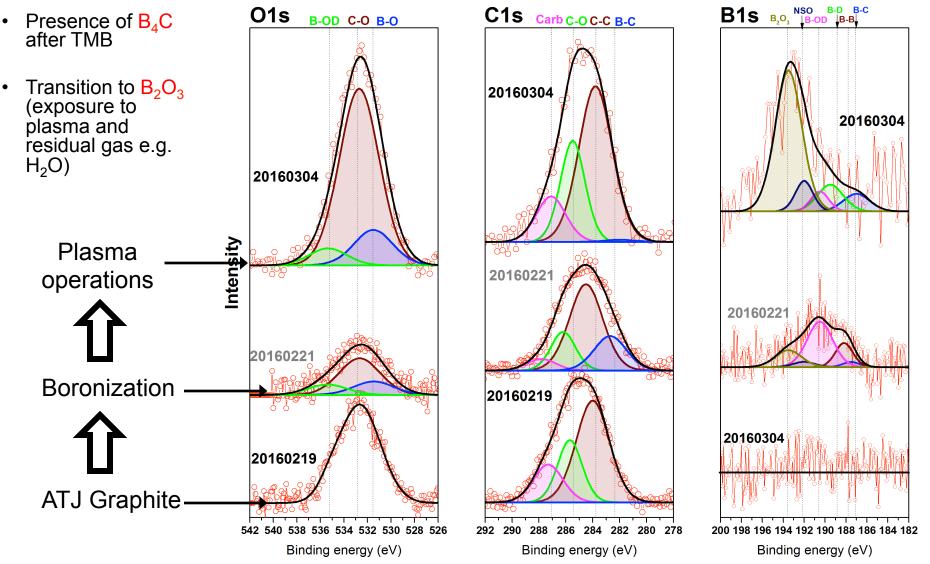


MAPP Methodology

- Data analysis:
 - Define sets of peaks per region to be fitted:
 - References and QCMD simulations (collaboration with P. Krstic)
 - Define resolution (min in FWHM of peaks):
 - Theoretical resolution (~2.0 eV) and experimental (~3.5 eV)
 - Define delta BE between peaks to fit:
 - Laboratory high resolution XPS at Princeton University
 - References*
 - The goal is to develop the best set of constraints in each region to allow objective and unique fittings. Since MAPP's data is continuously generated to develop a <u>standard</u> <u>data analysis routine</u> is critical.



Evolution of surfaces



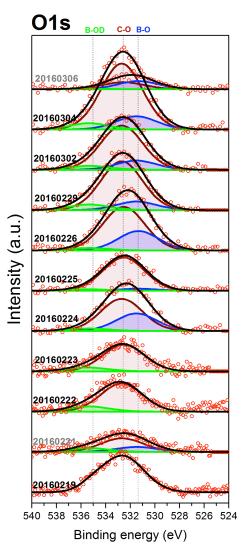
Transitions of surface chemistry

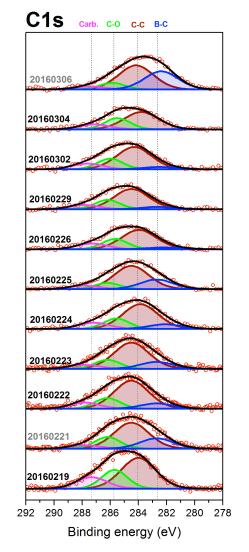
Regions

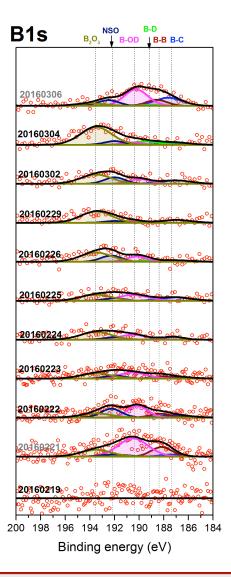
- Patterns:
 - Common features between boronizations
 - Evolution of components in each region
 - Oxidation
 - Sputtering

Surface transitions *smoothly* from carbide to oxide, additionally D+ erodes the coatings

* Gray font traces were collected ~30 min after boronization







🚺 NSTX-U

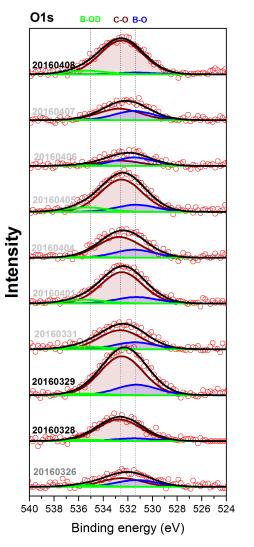
Transitions of surface chemistry

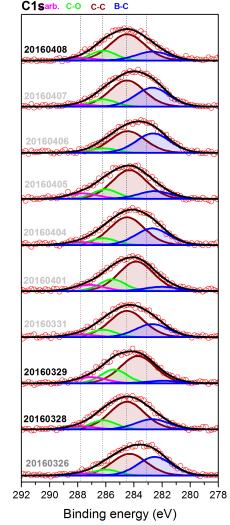
• Regions_{ATJ}

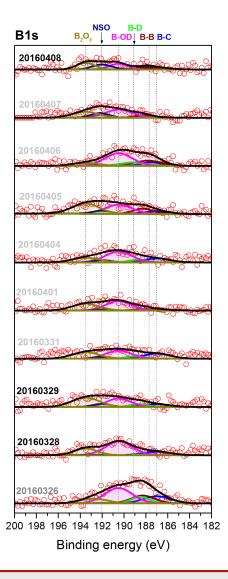
- Patterns:
 - Common features between boronizations
 - Evolution of components in each region
 - Oxidation
 - Sputtering
 - Effect of daily vs. weekly boronizations

The behavior seems to be the same in weekly vs. daily TMB, however small thickness accelerates the rate of erosion

** Gray font traces were collected ~30 min after boronization and plasma exposure



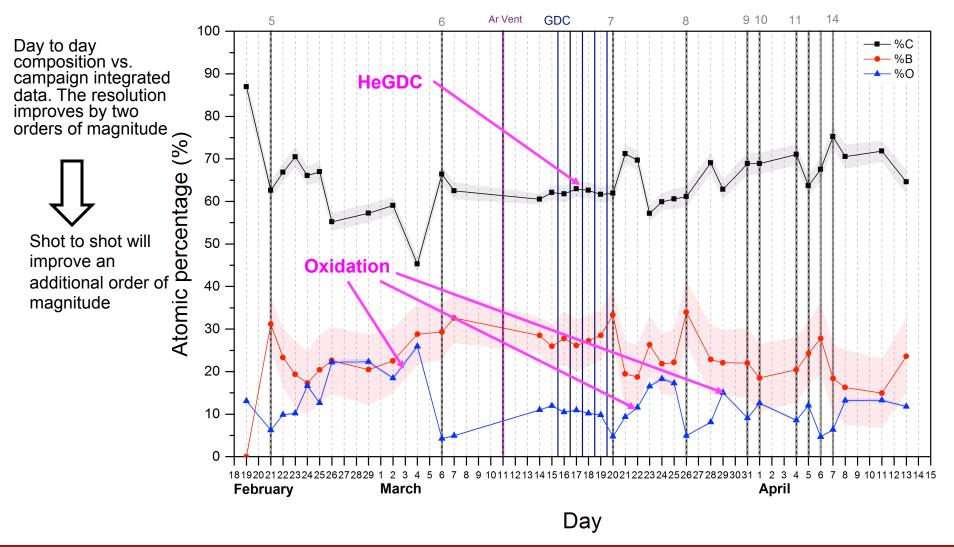




NSTX-U

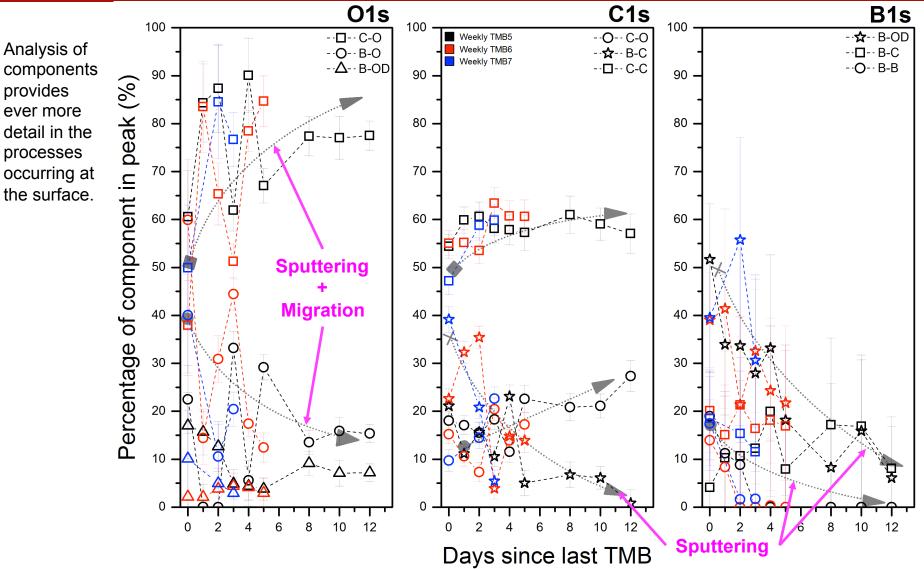
Daily recorded concentration

Atomic concentrations





Analysis of compounds



Upcoming experiments and plans for 2015/2016 (FY16) campaign

- More and more boronizations. Post-daily and pre plasmas XPS scans in daily boronization mode
- Laboratory experiments with boronized samples
 - Boronized samples stored in C128 ready for off-line irradiations
- B to Li transition XP
- Li related measurements
- Ongoing efforts to set up remote insertion to enable in between shots analysis:
 - Probe drive motor cabling and control
 - Between shots pumping configuration
 - Interlock signals and TIVs sync



Long-term plans for FY17-18

- MAPP will be developed to be a routinely used PMI diagnostic able to support a growing base of users
 - Our goal is to enable a user to also provide samples for in-vacuo testing and characterization
 - Support with basic training for data analysis if needed
 - Shot-to-shot data acquisition optimized
- MAPP full diagnostic suite will be commissioned by FY17 campaign
 - Direct recoil spectroscopy for direct D surface concentration
 - TDS and LEISS optimization with support from Princeton and UIUC



- Enhanced diagnostic suite in MAPP
 - Design of a backscattering low-energy ion scattering spectroscopy capability (to support Li-Mo and Li-W mixing experiments)
 - In-situ DC-QMB (dual-crysal quartz microbalance) compatible for high-temperature liquid-metal erosion and candidate solid PFC material erosion and re-deposition
 - hydrogen composition sensor to help quantify spectroscopic measurements at the MAPP surface. (collab. with R. Kolasinski)
- Integration of MAPP to OES measurements for multispatial diagnosis (collab. with V. Soukhanovskii and F. Scotti)